

DSAM Material Introduction



Content.

1. Company History
2. Product line-up
3. Cu-Graphene Paste/Powder
4. Ag Paste / Ag-Graphene Powder & ACH(Ag-Cu-Gr) Paste
5. Insulation Paste
6. Solder Paste
7. Epoxy Solder Paste
8. Solder Ball / Micro Solder Ball Flux / Non Clean Flux
9. Manufacturing line & Equipment
10. Packaging
11. Storage
12. Manufacture Company
13. Patent & Certification
14. R&D Technical Roadmap

1. Company History

1980

Founded
Daesung Metal

1990

Factory 1
(Incheon)



1990

Silver business
Metal recycling
manufacture

2003

Sputtering target
manufacture



2009

Factory 2
(Incheon)

Precious metal material
manufacture



2010~2012

Accessories business

Non-ferrous metal
Sputtering target
manufacture



2014

Komsco Enrollment

KRX GOLD manufacture



2021

Headquarters expansion
(Incheon, South Korea)

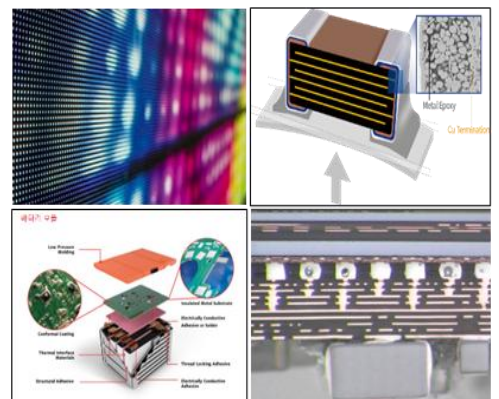


2020~

R&D Center

Electronic material development

- Cu-Graphene Powder & Paste/Ink
- Ag-Cu-Gr Paste & Ag Paste/Powder
- Solder Paste & Flux
- Epoxy Solder Paste
- Water Soluble Flux & Paste
- Ball Flux & Micro Ball Flux & Non-Clean Flux
- Epoxy Adhesive

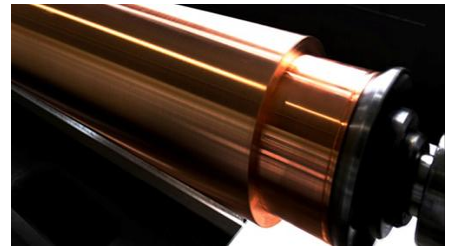
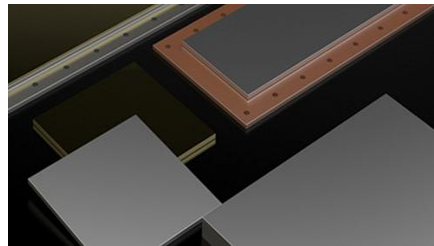


2. Product line-up

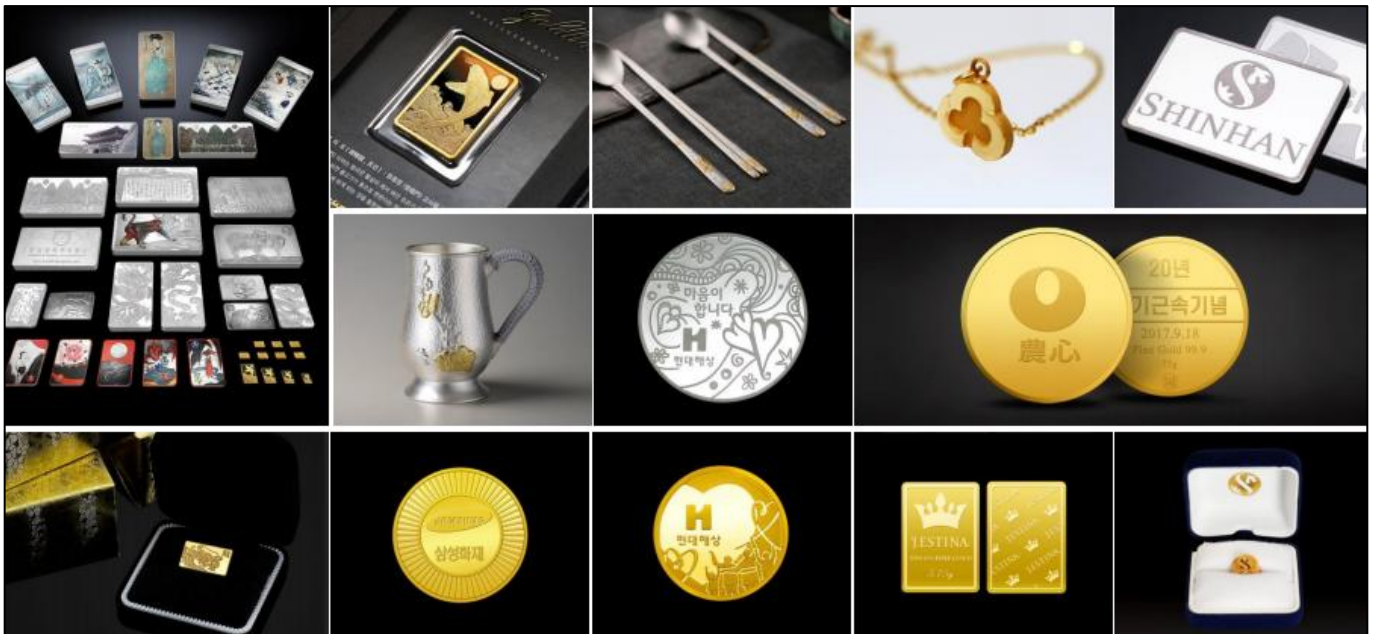
※ Sputtering Target

Material	Purity	G/S	Material	Purity	G/S	Material	Purity	G/S	
Ag	4N5	<50μm	Ni-Cr (80:20wt%)	3N5	<30μm	Cu	4N8	<100μm	
Au	4N	<80μm				Al	5N/4N		
Pd	3N5	<50μm				Ni	4N		
			Ni-V (93:7wt%)	3N5	<30μm	Ti	4N5		
			Ni-Cu (Monel)	4N		Al-1%Si	5N	<100μm	
							Al-0.8%Si	5N	<100μm

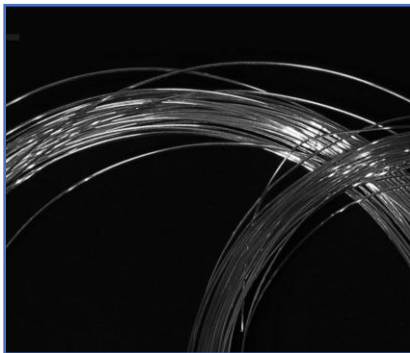
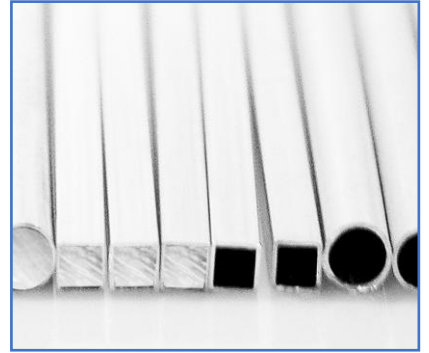
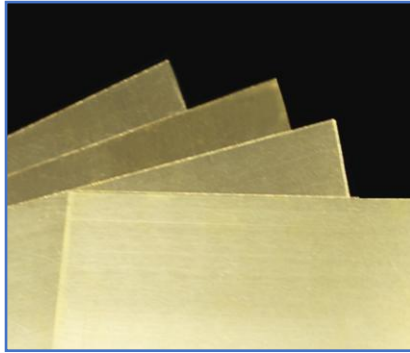
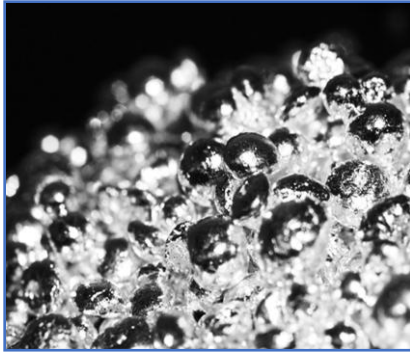
Cu Cylinder target



※ Silver / Gold Bar, Coin



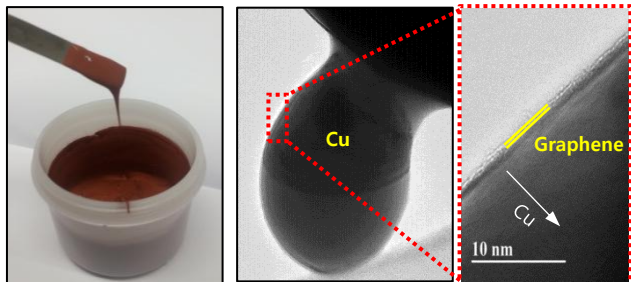
※ Ag & Au Product



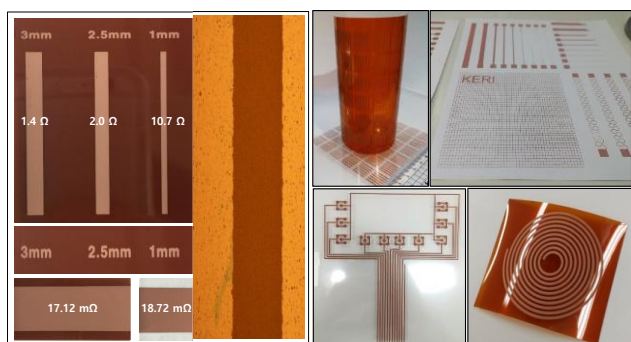
※ Plating material



3. Cu-Graphene Paste/Powder



Specific resistance



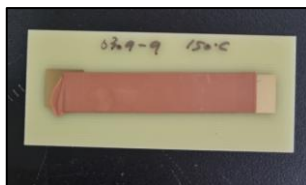
Cu-Graphene Paste

-. Particle Size

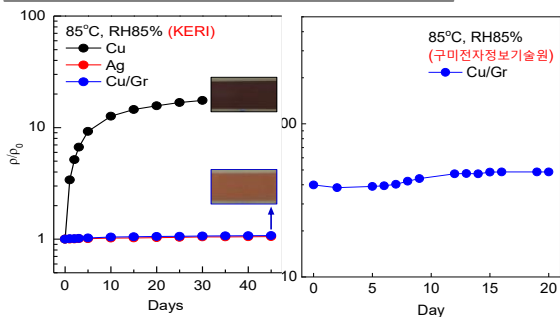
ITEM	Size	
	1.5μm	400nm
Vacumm N2 Oven	200°C 1hr	200°C 1hr
N2 Reflow	180°C 5min 250°C 20min	180°C 5min 230°C 20min

Air Oven Type (Metal & Silk Mask)

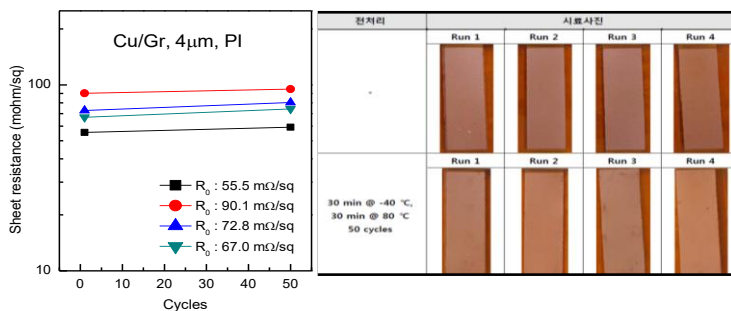
Cu-Graphene Paste



Temperature/Humidity test (85°C, 85%)



Thermal shock test (-40°C/30min~+80°C/30min, 50 cycle)

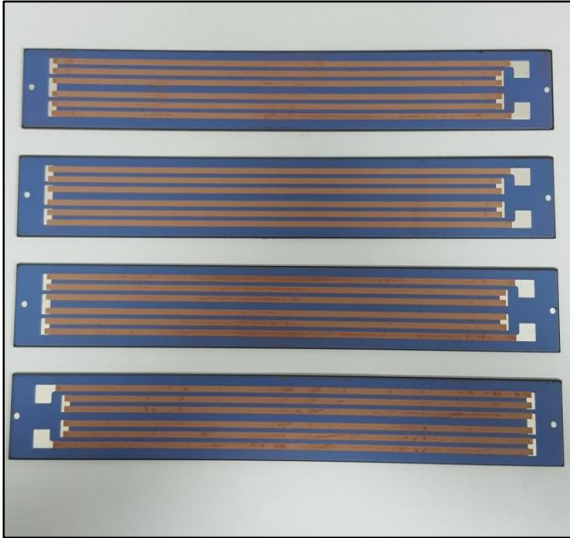


Product name	Particle Size	Specific resistance	Viscosity (cps)
DSAM-CG Series	1.5μm	3 mΩ.cm ↓	10,000~100,000
	400nm	3 mΩ.cm ↓	10,000~100,000
	1.5μm,400nm Hybrid	3 mΩ.cm ↓	10,000~100,000

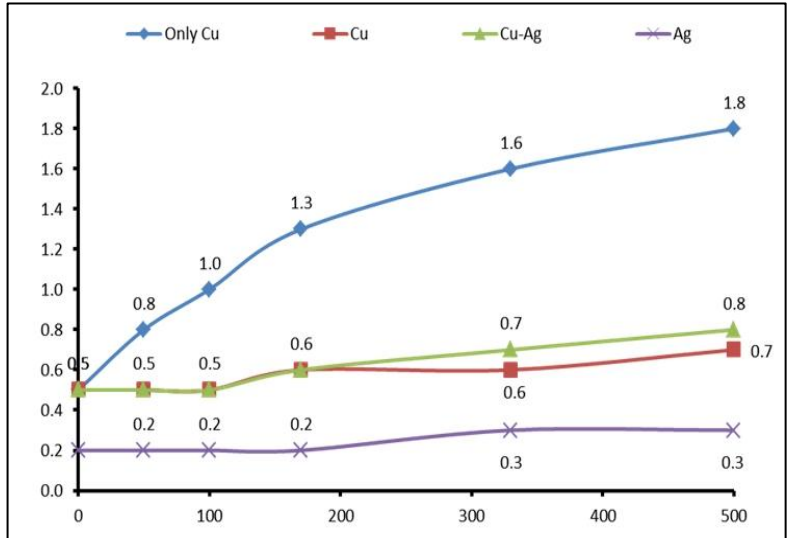
Application

Field	Purpose	Substrate	Advantage
Display Electrode	Ag → Cu-Graphene	Glass / Film	Low Cost
Touch panel	Ag → Cu-Graphene	PET / CPI / PI Film	Low Cost / High Flexible
Via Filling	Cu → Cu-Graphene	PCB / FPCB	Anti oxidation
Thick film heater	Ag, Pd → Cu-Graphene	SUS	Anti oxidation / High Fever

Application field



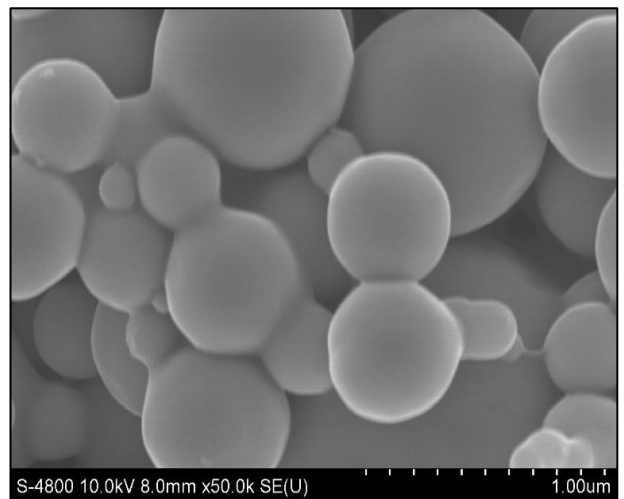
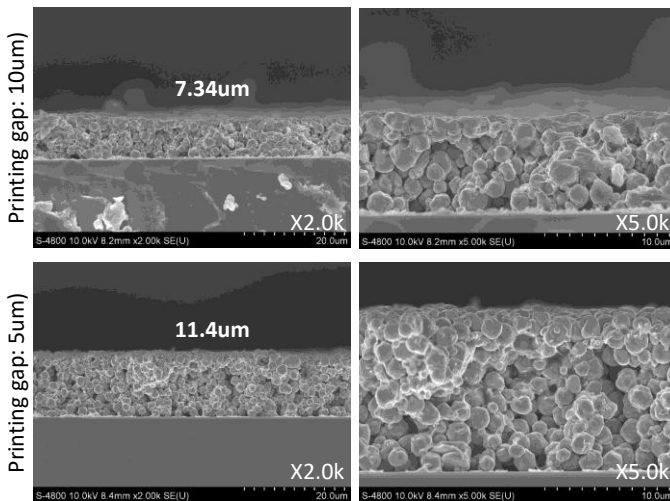
Reliability evaluation result



1. PTC heater (EV)
2. Pattern printing
3. Solar electrode circuit
4. Heat dissipation material
5. Via filling

※ Cu-Graphene has the same reliability as Ag.

SEM Image



- Binder Type

1. Epoxy : Via filling / Heat dissipation material
2. Polyester : Flexible Film
3. Acryl : Pattern printing / Pattern printing Etc.

4. Ag Paste / Ag-Graphene Powder & ACH(Ag-Cu-Gr) Paste



Ag-Graphene Paste Migration Test Result



Ag Paste & Ag-Cu-Graphene Paste

-. Particle Size

ITEM	Particle Size	
	1~10 um	0.6~0.8 um
Printable Thickness	5~50μm	5μm ↓
Heating Oven	Low Temp. 100~200 High Temp. 250~700°C 30~90min (Customized)	
Air Condition	Air/N2	Air/N2

-. Printing Type

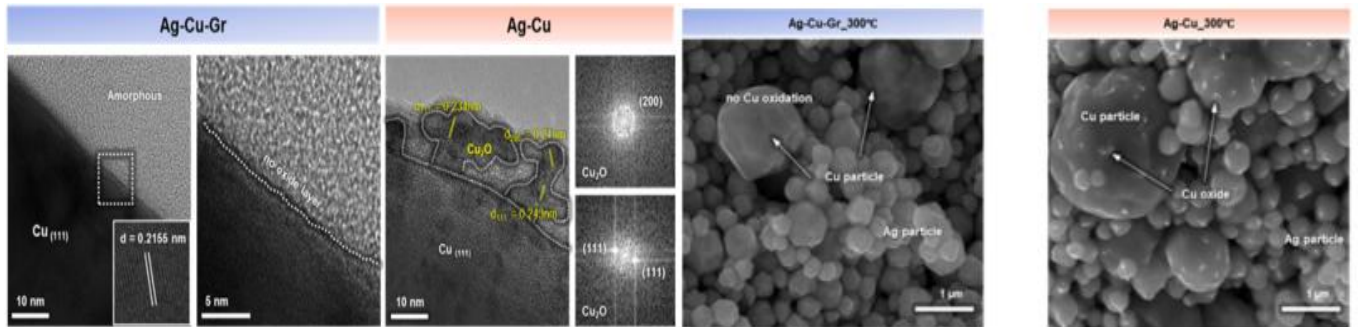
→ Etc. (Customizing)

-. Sintering Type : Heating, Light sintering

-. Low Temp. Type : 100~200°C

-. TGA : Sintering Ag or ACH Paste **Hume** : 10% ↓

-. bonding Type Adhesive **Epoxy Type** : 10.8 W/mk



Product name	Particle Size	Specific resistance (200°C)	Viscosity (cps)
DSAM-AG Series	Ag Micro+Nano	1 mΩ.cm ↓	10,000~100,000
	Ag Micro	1 mΩ.cm ↓	10,000~100,000
DSAM-ACH Series	Cu-Graphene 10~30%/ Ag	5~10 mΩ.cm ↓	10,000~100,000
	Cu-Graphene 40~60%/ Ag	3~5 mΩ.cm ↓	10,000~100,000

Application

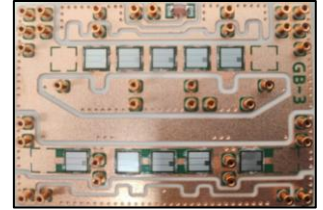
Field	Purpose	Substrate	Advantage
Display Electrode	Ag → Ag Nano	Glass / Film	Low Resistance
Touch panel	Ag → Ag-Cu-Graphene	PET / CPI / PI Film	Low Cost / High Flexible
LED Bonding	Ag → Ag-Cu-Graphene	PCB / FPCB	Low Cost / High Adhesiveness
Thick film heater	Ag, Pd → Ag-Cu-Graphene	SUS	Low Cost / High Fever

→ **DSAM-AG/ACH(Ag-Cu-Graphene) Series**

Introduction

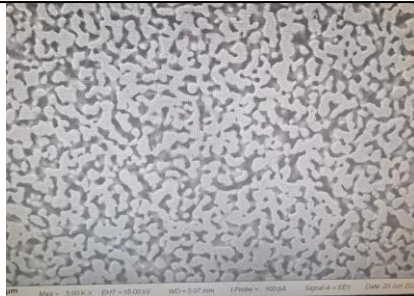
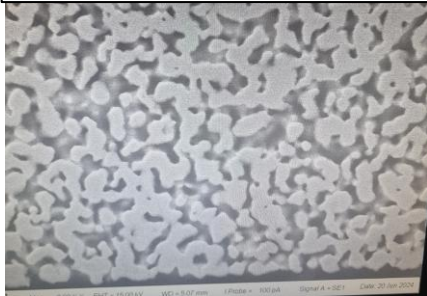
DSAM-AG/ACH products are composite bonding materials of Ag or Cu-Graphene and are pastes used for chip bonding and die attach.

It has high sintering performance and excellent bonding properties and can be used in both non-pressure and pressure processes.

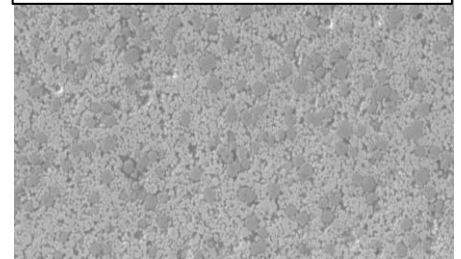


Item	Unit	DSAM-AG	DSAM-ACH (Ag-Cu-Graphene)	DSAM-CG (Cu-Graphene)
Viscosity(Pa.s)	Pa.s	10~50	10~50	10~50
Thixotropic Index(T.I)		0.4 ~ 1.0	0.4 ~ 1.0	0.4 ~ 1.0
Viscosity Recovery rate	%	Below 10	Below 10	Below 10
Powder Content	%	Silver 90	Silver 70~50 Cu-Graphene 20~40	Cu-Graphene 90
Thermal conductivity (250°C 120min Non-Pressure)	W/mk	200~250	120~150	N2/Vac.
TGA (250°C 30min)	%	90~93%	90~93%	90~93%
Color		Silver	Silver or Dark Silver	Brown
Sheet resistance (200°C 30min Non-Pressure)	mΩ/sq	1 ↓	10 ↓	N2/Vac. 50 ↓
Water contents in Paste	%	Less than 3.0	Less than 3.0	Less than 3.0

Non- Press Type AG Sintering Paste



Non- Press Type ACH Sintering Paste



AG							ACH							
Temperature °C	Model	Diffusivity mm ² /s	Conductivity W/(m ² K)	Cp J/gK	Pulse type		Temperature °C	Model	Diffusivity mm ² /s	Uncertainty %	Conductivity W/(m ² K)	Cp-table J/(g ² K)		
1	25.2	In-plane, i., heatl.	111.398	233.093	0.263	3 (long)	1	25.0	In-plane Isotropic(I)	42.097	0.1	125.029	0.330	
2	25.0	In-plane, i., heatl.	111.112	232.495	0.263	3 (long)	2	25.0	In-plane Isotropic(I)	42.230	0.1	125.424	0.330	
4	25.0	In-plane, i., heatl.	110.341	230.880	0.263	3 (long)	3	25.0	In-plane Isotropic(I)	42.104	0.1	125.050	0.330	
7	25.1	In-plane, i., heatl.	111.316	232.921	0.263	3 (long)								
9	24.9	In-plane, i., heatl.	111.169	232.612	0.263	3 (long)								
Mean:	25.0		111.067	232.400	0.263		Mean:	25.0	42.144		125.168	0.330		
Std. Dev.:	0.1		0.422	0.883	0.000		Std. Dev.:	0.0	0.075		0.222	0.000		

Working conditions

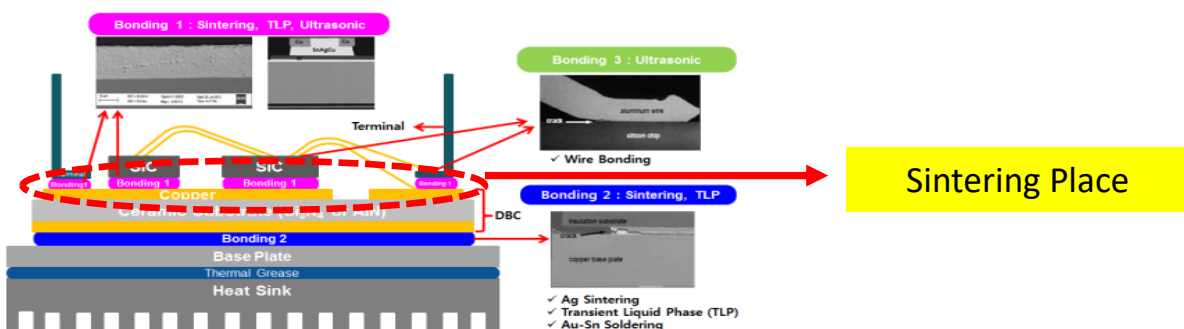
- Drying: 100°C 3min or 120°C 1min
- Temporary joint
 - NPR : After pre-drying, chip bonding and then main sintering.
 - PR : Temporary chip bonding after printing line drying is performed on a 5~10kg/100~150°C plate.
- Pressurized sintering conditions
 - Pressure: 20MPa ↓
 - Peak Temperature: 250~300°C
 - PR Hot Press Time: MAX. 3~5min
 - NPR Time: MAX. 60~120min
 - Atmosphere: Air or N2

※ Copper paste is prepared in a vacuum/ nitrogen atmosphere

Storage method

- Epoxy Type (EP)
 - Temperature: -10°C or lower / Thaw 1 hour before work
 - Storage period: 6 months
 - Disposal principle after operation at room temperature
- Resin Type(EC)
 - Temperature: 0~10°C / Thaw 1 hour before work
 - Storage period: 12 months
 - Disposal principle after operation at room temperature

※ If the above storage conditions are followed, the storage period is guaranteed.



5. Insulation Paste



Insulation Paste

-. Particle Size

ITEM	Size
	100nm~5um
Filler Content	50~60%
Heating Oven	150~300°C 30min
Air Condition	Air

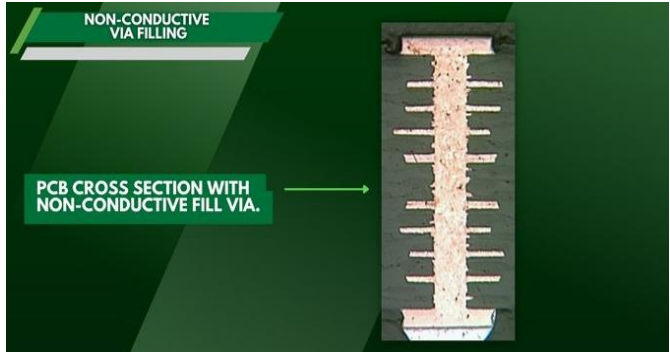
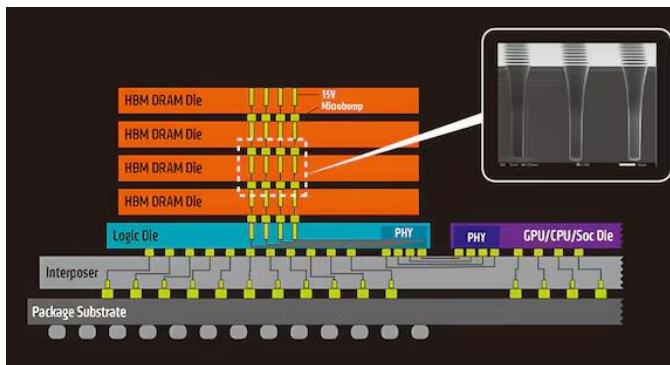
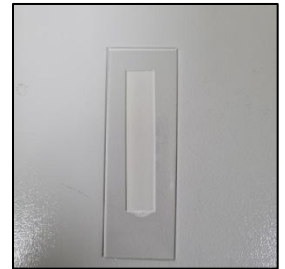
-. Printing Type

1. Screen Printing

-. Sintering Type : Heating

-. High Tg : 170~180°C

- Low Permittivity 3.0~3.2



Calculation Results

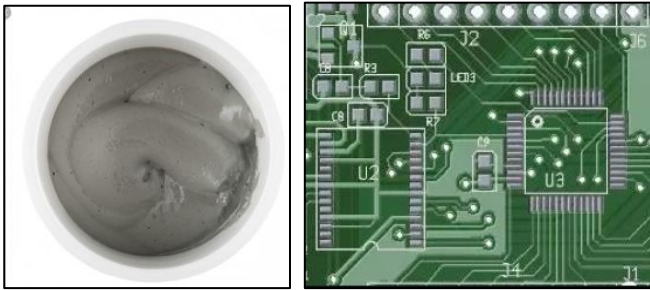
Nb	Thickness [mm]	Permittivity	Loss Tangent
1	0.09500	2.97887	1.55470e-02
2	0.09500	2.96794	1.55070e-02
3	0.09500	2.99637	1.57070e-02
4	0.09500	2.99483	1.56730e-02
5	0.09500	2.89231	1.53030e-02

Product name	Particle Size	Specific resistance (150°C)	Viscosity (cps)
DSAM-I Series	Micro or Nano	Insulation	10,000~100,000

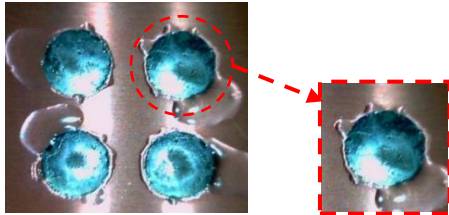
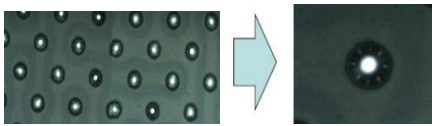
Application

Field	Purpose	Substrate	Advantage
Via Filling	-	PCB/FPCB Via Hole	High Tg / Low Cost
Heat dissipation	-	LED/Chiller system	Fast heat dissipation

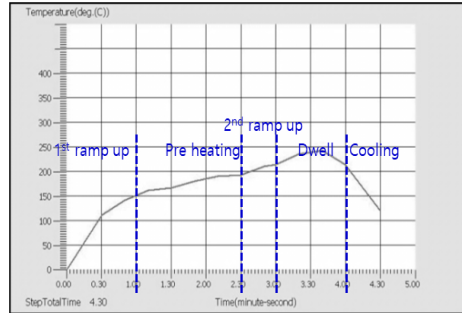
6. Solder Paste



Solder Ball & Wetting Test



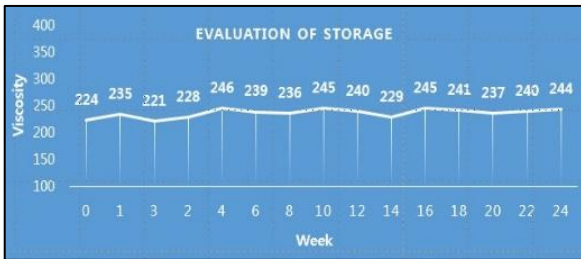
Solder Paste Reflow Profile



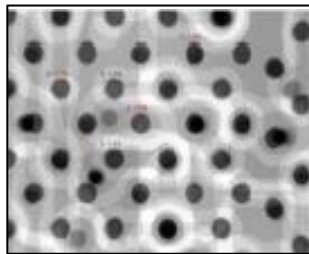
Pre heating			Dwell			Cooling	
Time	Peak(°C)	Max(°C)	Time	°C	Max(°C)	°C/sec	°C
144sec	150 ~ 190	200	72sec	215°C ↑	235 ~ 250	108sec	215~120

- Sintering Type : Heating (Reflow Oven)
- Viscosity change : 6 month / Rate of change 15% ↓
- Void : Max 7% ↓

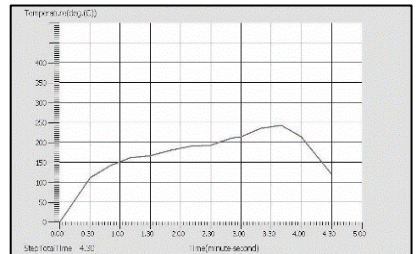
Viscosity Evaluation Result



Void Test (Max. 3%↓)



Reflow Profile

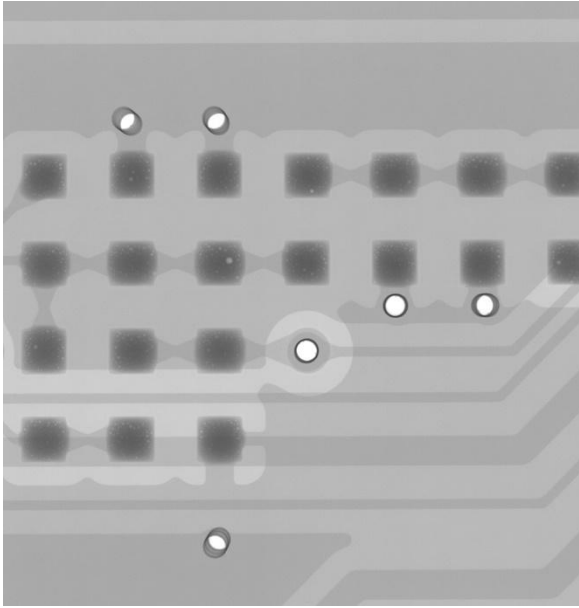


Product name	Viscosity (Pa.s)	Alloy	Printing Guarantee Time	Other
DSAM-U/P/I Type6~Type9	200±50	SnAg3.0Cu0.5/SnCu0.7/In8	12h	Solvent Soluble : S Water Soluble : W
	200±50	SnAg3.0Cu0.5, S	12h	
	200±50	SnAg3.0Cu0.5, W	12h	
	200±50	SnIn8Ag3.5Bi0.5	12h	

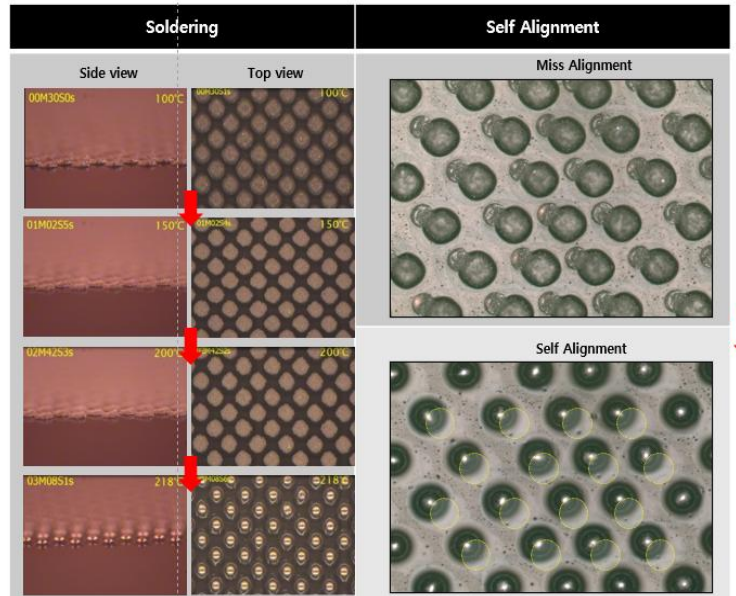
Application

Field	Purpose	Substrate	Advantage
PCB Bumping	High Printability	PCB / FPCB	Low Viscosity Change Low Void Low Cost Fast delivery
SMT (MLCC)	High Printability	PCB / FPCB	
Chip Bonding	High Tackiness	PCB / FPCB	

Void / Soldering

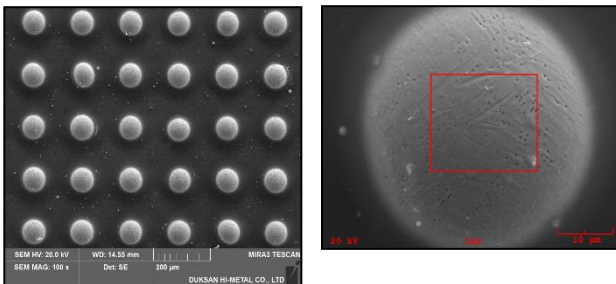


▶ Soldering 성 및 Self Alignment 평가 결과



1. Low Void (Max. 7% ↓)
2. Self alignment Test PASS

IMC Data (SEM)

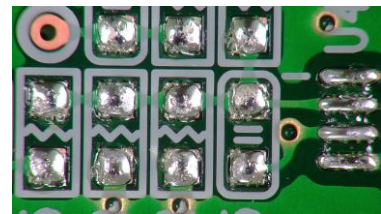
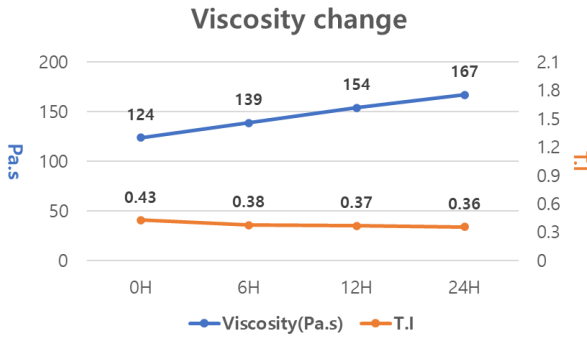
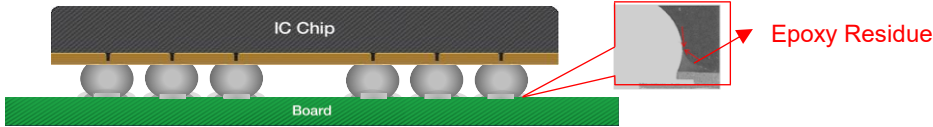


▶ IMC / Surface 평가 결과

	X-section	IMC	EDS																																																																																
Ref.			<table border="1"> <thead> <tr> <th>El.</th> <th>Line</th> <th>Intensity</th> <th>Con.</th> <th>Unit</th> <th>Elem.</th> <th>Stdev.</th> <th>SD%</th> </tr> </thead> <tbody> <tr> <td>P</td> <td>Kα</td> <td>65.85</td> <td>2.47%</td> <td>wt%</td> <td>0.114</td> <td>0.152</td> <td>-</td> </tr> <tr> <td>Ni</td> <td>Kα</td> <td>14.47</td> <td>1.45%</td> <td>wt%</td> <td>0.124</td> <td>0.156</td> <td>-</td> </tr> <tr> <td>Cu</td> <td>Kα</td> <td>201.26</td> <td>25.54%</td> <td>wt%</td> <td>0.558</td> <td>0.690</td> <td>-</td> </tr> <tr> <td>Pb</td> <td>La</td> <td>17.80</td> <td>2.34%</td> <td>wt%</td> <td>0.201</td> <td>0.266</td> <td>-</td> </tr> <tr> <td>Ag</td> <td>La</td> <td>20.40</td> <td>2.76%</td> <td>wt%</td> <td>0.234</td> <td>0.304</td> <td>-</td> </tr> <tr> <td>Sr</td> <td>La</td> <td>292.56</td> <td>41.02%</td> <td>wt%</td> <td>0.760</td> <td>0.975</td> <td>-</td> </tr> <tr> <td>As</td> <td>La</td> <td>11.55</td> <td>1.21%</td> <td>wt%</td> <td>1.066</td> <td>1.334</td> <td>-</td> </tr> <tr> <td>Ph</td> <td>La</td> <td>8.76</td> <td>1.14%</td> <td>wt%</td> <td>1.430</td> <td>1.802</td> <td>-</td> </tr> <tr> <td>-</td> <td>-</td> <td>-</td> <td>100.00%</td> <td>wt%</td> <td>-</td> <td>-</td> <td>Total</td> </tr> </tbody> </table>	El.	Line	Intensity	Con.	Unit	Elem.	Stdev.	SD%	P	Kα	65.85	2.47%	wt%	0.114	0.152	-	Ni	Kα	14.47	1.45%	wt%	0.124	0.156	-	Cu	Kα	201.26	25.54%	wt%	0.558	0.690	-	Pb	La	17.80	2.34%	wt%	0.201	0.266	-	Ag	La	20.40	2.76%	wt%	0.234	0.304	-	Sr	La	292.56	41.02%	wt%	0.760	0.975	-	As	La	11.55	1.21%	wt%	1.066	1.334	-	Ph	La	8.76	1.14%	wt%	1.430	1.802	-	-	-	-	100.00%	wt%	-	-	Total
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As	La	11.55	1.21%	wt%	1.066	1.334	-																																																																												
Ph	La	8.76	1.14%	wt%	1.430	1.802	-																																																																												
-	-	-	100.00%	wt%	-	-	Total																																																																												
D S M T			<table border="1"> <thead> <tr> <th>El.</th> <th>Line</th> <th>Intensity</th> <th>Con.</th> <th>Unit</th> <th>Elem.</th> <th>Stdev.</th> <th>SD%</th> </tr> </thead> <tbody> <tr> <td>P</td> <td>Kα</td> <td>76.76</td> <td>2.80%</td> <td>wt%</td> <td>0.120</td> <td>0.160</td> <td>-</td> </tr> <tr> <td>Ni</td> <td>Kα</td> <td>15.95</td> <td>1.83%</td> <td>wt%</td> <td>0.120</td> <td>0.162</td> <td>-</td> </tr> <tr> <td>Cu</td> <td>Kα</td> <td>192.91</td> <td>19.15%</td> <td>wt%</td> <td>0.473</td> <td>0.590</td> <td>-</td> </tr> <tr> <td>Pb</td> <td>La</td> <td>16.59</td> <td>2.18%</td> <td>wt%</td> <td>0.190</td> <td>0.254</td> <td>-</td> </tr> <tr> <td>Ag</td> <td>La</td> <td>18.68</td> <td>2.47%</td> <td>wt%</td> <td>0.227</td> <td>0.308</td> <td>-</td> </tr> <tr> <td>Sr</td> <td>La</td> <td>284.62</td> <td>46.36%</td> <td>wt%</td> <td>0.838</td> <td>1.038</td> <td>-</td> </tr> <tr> <td>As</td> <td>La</td> <td>12.19</td> <td>1.18%</td> <td>wt%</td> <td>1.080</td> <td>1.360</td> <td>-</td> </tr> <tr> <td>Ph</td> <td>La</td> <td>9.40</td> <td>1.04%</td> <td>wt%</td> <td>1.484</td> <td>1.902</td> <td>-</td> </tr> <tr> <td>-</td> <td>-</td> <td>-</td> <td>100.00%</td> <td>wt%</td> <td>-</td> <td>-</td> <td>Total</td> </tr> </tbody> </table>	El.	Line	Intensity	Con.	Unit	Elem.	Stdev.	SD%	P	Kα	76.76	2.80%	wt%	0.120	0.160	-	Ni	Kα	15.95	1.83%	wt%	0.120	0.162	-	Cu	Kα	192.91	19.15%	wt%	0.473	0.590	-	Pb	La	16.59	2.18%	wt%	0.190	0.254	-	Ag	La	18.68	2.47%	wt%	0.227	0.308	-	Sr	La	284.62	46.36%	wt%	0.838	1.038	-	As	La	12.19	1.18%	wt%	1.080	1.360	-	Ph	La	9.40	1.04%	wt%	1.484	1.902	-	-	-	-	100.00%	wt%	-	-	Total
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- IMC Data
1. Alloy IMC formation PASS
 2. Reliability Test PASS

7. Epoxy Solder Paste



※ Dry Test (150°C 24hr)

	Before	After
Alumina		
Glass		

Epoxy Solder Paste

1. Screen Printing
 2. Dotting Printing
 3. Etc. (Customizing)
- Stencil life : 6h ↑
 - DST : SAC305 20~30% ↑
 - Void : Max 7% ↓
 - Low yellow Index

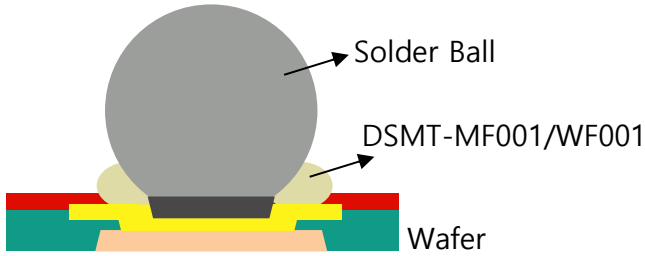
Product name	Viscosity (Pa.s)	Alloy	Printing Guarantee Time	Other
DSAM-U/P E Type6~7	20~200	SnAg3.0Cu0.5 SnAg3.0Cu0.5/SnCu0.7/In8	8h	Screen : S Pin Dotting : P

Application

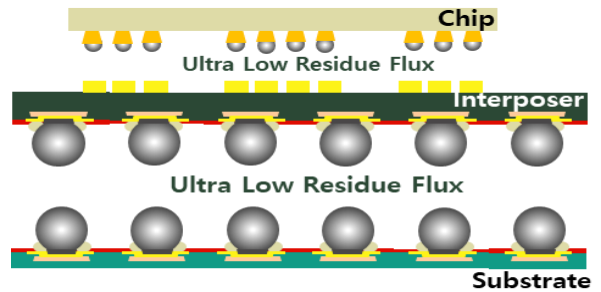
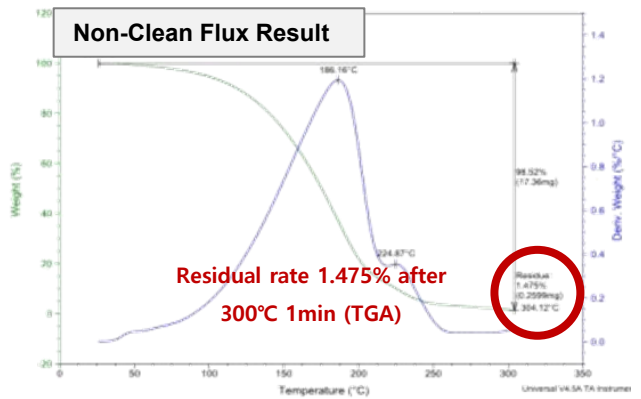
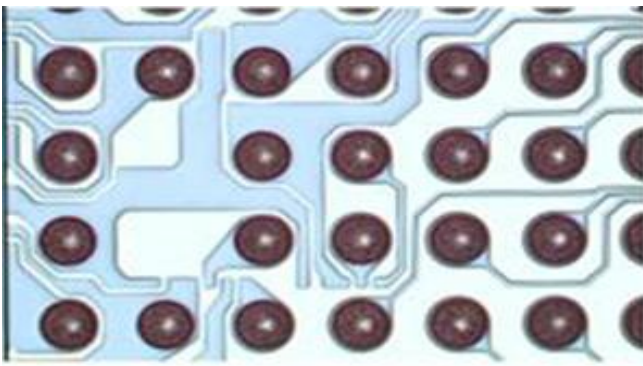
Field	Purpose	Substrate	Advantage
PCB Bumping	High Strength	PCB / FPCB	Low Viscosity Change Low Void Low Cost Fast delivery
LED Bonding	High Transparency	Lead frame	

8. Solder Ball / Micro Solder Ball Flux / Non Clean Flux

Product Image



< application of Ball Flux >



< Application of POP package >

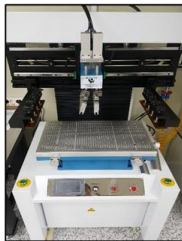
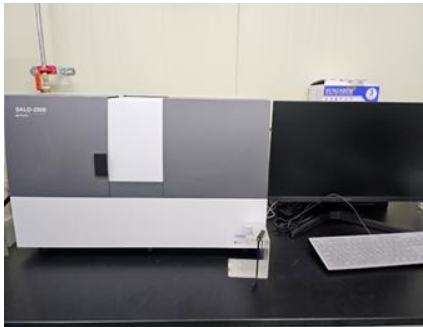
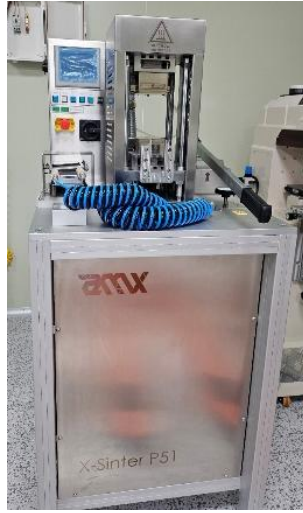
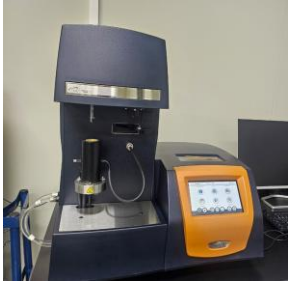
Product name	Viscosity (Pa.s)	Cleaning Type	Printing Guarantee Time	Other
DSAM-WF/MF/NF	10~150	Solvent Soluble	12h	Screen Type or Pin Dotting Type
	10~100	Water Soluble	12h	
	10~50	Non Clean	12h	

Application

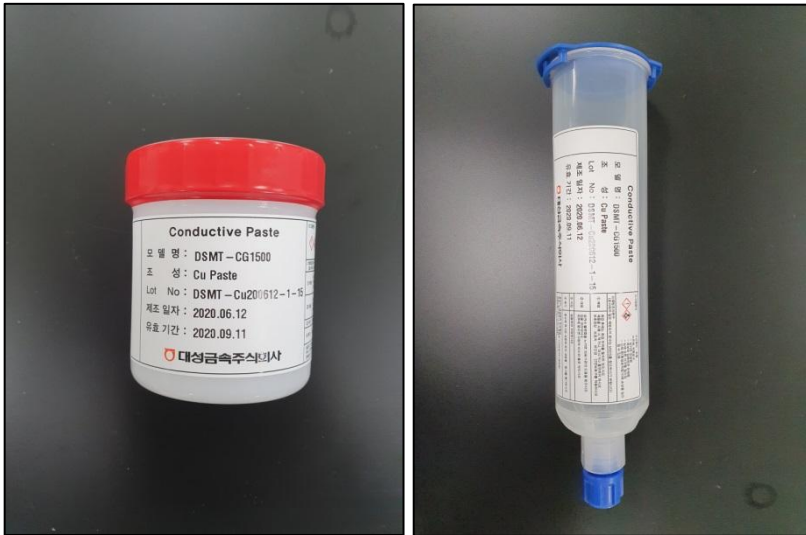
Field	Purpose	Substrate	Advantage
PCB Bumping	High Activation / Adhesiveness	PCB / FPCB	Low Viscosity Change Low Cost High Quality Fast delivery
Solder Ball Bonding	High Activation	PCB / FPCB	

9. Manufacturing line & Equipment

- Clean Room (10,000 Class ↓)
- Dispersion equipment
- Analysis equipment
- Reliability equipment



10. Packaging



- 6oz / 5cc/ 10cc / 30cc Syringe
- 500g Jar
- 150mℓ Jar (Ball Flux)
- 1kg Jar
- 2kg Jar

11. Storage

- Storage Standard : 150mL jar packing & refrigerator storage
- Storage Place
 1. Nomal Solder Paste/Flux : Refrigerator (Below 10°C)
 3. Cu-Graphene/Ag/ACH Paste/Epoxy Solder
 - Epoxy Type (EP)

Temperature: -10°C or lower / Thaw 1 hour before work
Storage period: 6 months
Disposal principle after operation at room temperature

 - Resin Type(EC)

Temperature: 0~10°C / Thaw 1 hour before work
Storage period: 12 months

12. Manufacture Company

- Company Name : DAESUNG METAL
- Address : 89, Bukhang-ro 120 beon-gil, Seo-gu, Incheon, Republic of Korea
- T +82 32)575-8547 / M +82 10-6625-8013 / E-mail leesangmin0529@dsmetal.com



13. Patent & Certification



13. Patent & Certification



14. R&D Technical Roadmap

Mid- to long-term Technical Load Map

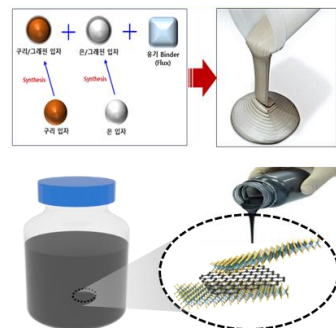


PKG Material	Non Clean Flux (Less than 1% residue)	Non Clean Solder Paste
	Micro Solder Ball WS Flux	Type7 Epoxy Solder Paste
Conductive Material	Type9~10 Solder Paste	
	Car heating paste	Power semiconductor copper-silver hybrid paste
	Copper-graphene bonding paste	
Basic Material	Power semiconductor silver paste	Micro LED bonding paste
	Powder for batteries Ag Powder D50 50~100nm	Ag Powder D50 5~10um Flake
	Powder for contact Ag Powder D50 30~50um	Ag-Graphene Nano Powder

Electronic material development

Cu-Graphene Powder & Paste/Ink	Epoxy Solder Paste
Ag-Cu-Gr Paste & Ag Paste/Powder	Water Soluble Flux & Paste
Solder Paste	Ball Flux & Micro Ball Flux & Non-Clean Flux
Solder Flux/Non Clean Flux	Epoxy Adhesive

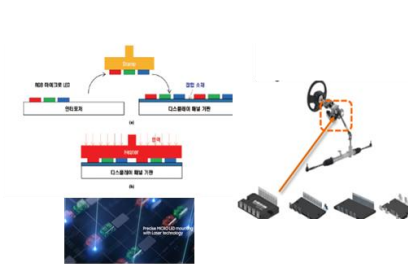
Nanoparticles and Metal-Graphene Particles
Next-Generation Pastes and Fluxes



Electrical/Semiconductor Bonding Materials
Substrate Electrodes and Heat Dissipation Materials



Research on next-generation micro LED and power semiconductor bonding paste materials



Infinite passion n innovation!

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Incheon, Republic of Korea



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